

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination DEFEO ET AL.	
		Examiner Patricia L. Hailey	Art Unit 1755	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,416,620	07-2002	Narancic et al.	162/5
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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